7F-7, No. 3, Wu Chuan 1st Road, New Taipei Industrial Park, New Taipei City, Taiwan, R.O.C. Tel.: 886-2-22991331 Fax: 886-2-22982466

SPECIFICATION FOR

Ultra High-Q and Low ESR MULTILAYER CERAMIC CHIP

CAPACITORS

Series: RF Series

Description: <u>Ultra Hi-Q & Low ESR MULTILAYER CERAMIC CHIP</u>

CAP.

Size 0201~0805, NPO, 25V to 250V

RoHS Compliant & Halogen Free

<u>DRAWN BY</u>	<u>CHECKED BY</u>	<u>APPROVED BY</u>
蕭敏珍	蔡永承	巫宏俊



1. INTRODUCTION

MLCC consists of a conducting material and electrodes. To manufacture a chip-type SMT and achieve miniaturization, high density and high efficiency, ceramic condensers are used.

Hitano RF series MLCC is used at high frequencies generally have a small temperature coefficient of capacitance, typical within the ± 30 ppm/°C required for NP0 (C0G) classification and have excellent conductivity internal electrode. Thus, our RF series MLCC will be with the feature of low ESR and high Q characteristics.

2. FEATURES

- a. High Q and low ESR performance at high frequency.
- b. Ultra low capacitance to 0.1pF.
- c. Can offer high precision tolerance to $\pm 0.05 pF$.
- d. Quality improvement of telephone calls for low power loss and better performance.
- e. RoHS compliant
- f. HALOGEM compliant

3. APPLICATIONS

- a. Telecommunication products & equipments: Mobile phone, WLAN, Base station.
- b. RF module: Power amplifier, VCO.
- c. Tuners.

4. HOW TO ORDER

<u>RF</u>	<u>0603</u>	<u>N</u>	<u>100</u>	<u>J</u>	<u>500</u>	<u>C</u>	<u>T</u>
<u>Series</u>	Size	<u>Dielectric</u>	<u>Capacitance</u>	Tolerance	Rated voltage	<u>Termination</u>	Packaging
RF=Ultra High Q & Low ESR	0201 (0603) 0402 (1005) 0603 (1608) 0805 (2012)	N=NP0 (C0G)	Two significant digits followed by no. of zeros. And R is in place of decimal point. eg.: 0R5=0.5pF 1R0=1.0pF 100=10x10 ⁰ =10pF	A=±0.05pF B=±0.1pF C=±0.25pF D=±0.5pF F=±1% G=±2% J=±5%	Two significant digits followed by no. of zeros. And R is in place of decimal point. 6R3=6.3 VDC 100=10 VDC 250=25 VDC 500=50 VDC 101=100 VDC 251=250 VDC	C=Cu/Ni/Sn	T=7" reeled G= 13" reeled



5. EXTERNAL DIMENSIONS

Size Inch (mm)	L (mm)	W (mm)	T (mm)/Symbol		Remark	M _B (mm)
0201 (0603)	0.60±0.03	0.30±0.03	0.30±0.03	L	#	0.15±0.05
0402 (1005)	1.00±0.05	0.50±0.05	0.50±0.05	N	#	0.25+0.05/-0.10
0603 (1608)	1.60±0.10	0.80±0.10	0.80±0.07	s		0.40±0.15
0805 (2012)	2.00±0.20	1.25±0.20	0.85±0.10	Т		0.50±0.20

Fig. 1 The outline of MLCC

6. GENERAL ELECTRICAL DATA

W GET ELECTRICITE DITTI					
Dielectric	NP0				
Size	0201, 0402, 0603,0805				
Capacitance*	0201: 0.1pF to 33pF; 0402: 0.1pF to 22pF; 0603: 0.3pF to 47pF; 0805: 0.3pF to 100pF				
	Cap \leq 5pF: A (\pm 0.05pF), B (\pm 0.1pF), C (\pm 0.25pF)				
Capacitance tolerance	5pF <cap<10pf: (±0.1pf),="" (±0.25pf),="" (±0.5pf)<="" b="" c="" d="" th=""></cap<10pf:>				
	Cap≥10pF: F (±1%), G (±2%), J (±5%)				
Rated voltage (WVDC)	6.3V, 10V, 25V, 50V, 100V, 250V				
Q*	Cap≥30pF, Q≥1000; Cap<30pF,Q≥400+20C				
Insulation resistance at Ur	≥10GΩ				
Operating temperature	-55 to +125°C				
Capacitance change	±30ppm/°C				
Termination	Ni/Sn (lead-free termination)				

^{*} Measured at the conditions of 25°C ambient temperature and 30~70% related humidity.

 $Apply \ 1.0 \pm 0.2 Vrms, \ 1.0 MHz \pm 10\% \ for \ Cap \leq 1000 pF \ and \ 1.0 \pm 0.2 Vrms, \ 1.0 kHz \pm 10\% \ for \ Cap > 1000 pF.$

[#] Reflow soldering only is recommended.



7. CAPACITANCE RANGE

	DIELECTRIC							NP0					
	SIZE		0201		04	02		0603			0805		T
RAT	TED VOLTAGE (VDC)	6.3	10	25	50	100	50	100	250	50	100	250	Tolerance
	0.1pF (0R1)	L	L	L	N	N							В
	0.2pF (0R2)	L	L	L	N	N							A, B
	0.3pF (0R3)	L	L	L	N	N	S	S	S	T	T	T	A, B
	0.4pF (0R4)	L	L	L	N	N	S	S	S	T	T	T	A, B
	0.5pF (0R5)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	0.6pF (0R6)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	0.7pF (0R7)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	0.8pF (0R8)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	0.9pF (0R9)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	1.0pF (1R0)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	1.2pF (1R2)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	1.5pF (1R5)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	1.8pF (1R8)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	2.2pF (2R2)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	2.7pF (2R7)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	3.3pF (3R3)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	3.9pF (3R9)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	4.7pF (4R7)	L	L	L	N	N	S	S	S	T	T	T	A, B, C
	5.6pF (5R6)	L	L	L	N	N	S	S	S	T	T	T	B, C, D
Capacitance	6.8pF (6R8)	L	L	L	N	N	S	S	S	T	T	T	B, C, D
cita	8.2pF (8R2)	L	L	L	N	N	S	S	S	T	T	T	B, C, D
ıba	10pF (100)	L	L	L	N	N	S	S	S	T	T	T	F, G, J
೦	11pF (110)	L	L	L	N		S	S	S	T	T	T	F, G, J
	12pF (120)	L	L	L	N		S	S	S	T	T	T	F, G, J
	13pF (130)	L	L	L	N		S	S	S	T	T	T	F, G, J
	15pF (150)	L	L	L	N		S	S	S	T	T	T	F, G, J
	16pF (160)	L	L	L	N		S	S	S	T	T	T	F, G, J
	18pF (180)	L	L	L	N		S	S	S	T	T	T	F, G, J
	20pF (200)	L	L	L	N		S	S	S	T	T	T	F, G, J
	22pF (220)	L	L		N		S	S	S	T	T	T	F, G, J
	24pF (240)	L	L				S	S	S	T	T	T	F, G, J
	27pF (270)	L	L				S	S	S	T	T	T	F, G, J
	30pF (300)	L	L				S	S	S	T	T	T	F, G, J
	33pF (330)	L	L				S	S	S	T	T	T	F, G, J
	36pF (360)						S	S	S	T	T	T	F, G, J
	39pF (390)						S	S	S	T	T	T	F, G, J
	43pF (430)						S	S	S	T	T	T	F, G, J
	47pF (470)						S	S	S	T	T	T	F, G, J
	56pF (560)									T	T	T	F, G, J
	68pF (680)									T	T	T	F, G, J
	82pF (820)									T	T	T	F, G, J
	100pF (101)									T	T	T	F, G, J

^{1.} The letter in cell is expressed the symbol of product thickness.

8. PACKAGING DIMENSION AND QUANTITY

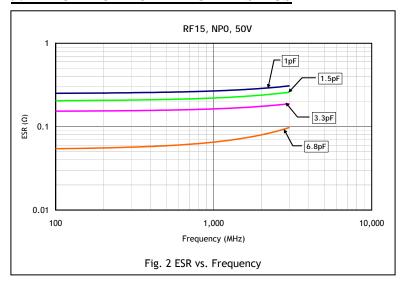
Size	Thiolmaga (mm)/Symbol		Paper tape		
Size	Thickness (mm)/Symbol		7" reel	13" reel	
0201 (0603)	0.30±0.03	L	15k	70K	
0402 (1005)	0.50±0.05	N	10k	50k	
0603 (1608)	0.80±0.07	S	4K	10K	
0805 (2012)	0.85±0.10	T	4k	15k	

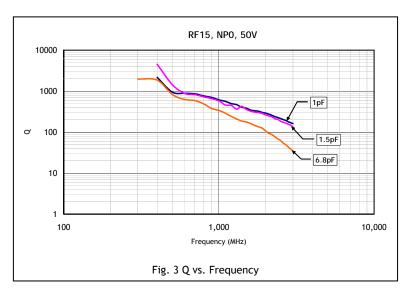
Unit: pieces

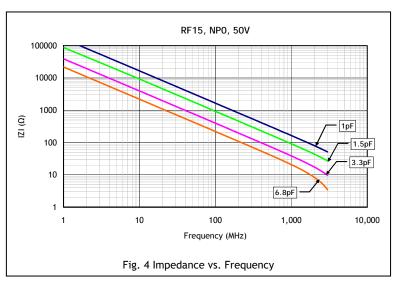
^{2.} For more information about products with special capacitance or other data, please contact PDC local representative.



9. ELECTRICAL CHARACTERISTICS

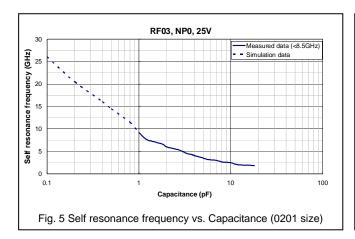


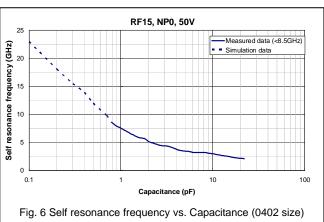


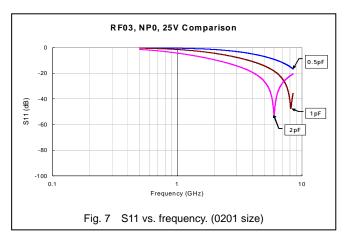


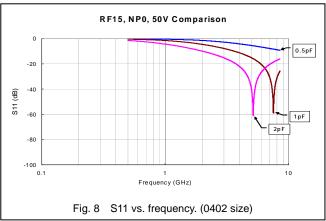


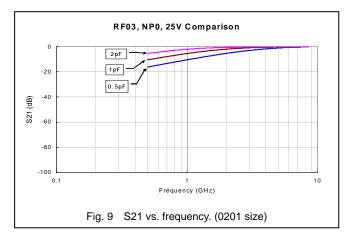
9. ELECTRICAL CHARACTERISTICS(Con.)

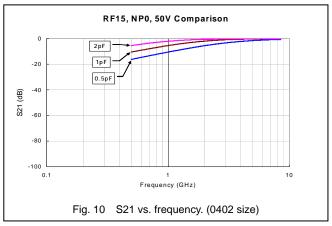














10. RELIABILITY TEST CONDITIONS AND REQUIREMENTS

No.	Item		Test Conditions		Requirements
1.	Visual and				* No remarkable defect.
	Mechanical				* Dimensions to conform to individual specification sheet.
2.	Capacitance	1.0±0.2Vri	ns, 1MHz±10%		* Shall not exceed the limits given in the detailed spec.
3.	Q/ D.F.	At 25°C ar	nbient temperature.		* Cap≥30pF, Q≥1000; Cap<30pF,Q≥400+20C
	(Dissipation				
	Factor)				
4.	Dielectric	* To apply	To apply voltage:		* No evidence of damage or flash over during test.
	Strength	≤100V,	≥250% of rated voltage.		
		250V,	≥200% of rated voltage.		
		* Duration	: 1 to 5 sec.		
		* Charge a	nd discharge current less than 50mA.		
5.	Insulation	To apply ra	ated voltage for max. 120 sec.		≥10GΩ
	Resistance				
6.	Temperature	With no el	ectrical load.		* Capacitance change: within ±30ppm/°C
	Coefficient	Operating	temperature: -55~125°C at 25°C		
7.	Adhesive	* Pressuriz	ring force :		* No remarkable damage or removal of the terminations.
	Strength of	0201: 21	N		
	Termination	0402 &	0603: 5N		
		>0603:	10N		
		* Test time	e: 10±1 sec.		
8.	Vibration	* Vibration	n frequency: 10~55 Hz/min.		* No remarkable damage.
	Resistance	* Total am	plitude: 1.5mm		* Cap change and Q/D.F.: To meet initial spec.
		* Test time	e: 6 hrs. (Two hrs each in three mutual	lly perpendicular	
		directions.)		
9.	Solderability	* Solder te	emperature: 235±5°C		95% min. coverage of all metalized area.
			time: 2±0.5 sec.		
10.	Bending Test	-	dle part of substrate shall be pressurize	-	* No remarkable damage.
		Ē.	ng rod at a rate of about 1 mm per seco		* Cap change: within ±5.0% or ±0.5pF whichever is larger.
		-	becomes 1 mm and then the pressure	shall be maintained	(This capacitance change means the change of capacitance under
		for 5±1 sec			specified flexure of substrate from the capacitance measured before the
11	D • • •		ment to be made after keeping at roon	n temp. for 24±2 hrs	
11.	Resistance to	1	emperature: 270±5°C		* No remarkable damage.
	Soldering Heat	1. 0	time: 10±1 sec	· 41	* Cap change: within ±2.5% or ±0.25pF whichever is larger.
			ng: 120 to 150°C for 1 minute before in a eutectic solder.	immerse the	* Q/D.F., I.R. and dielectric strength: To meet initial requirements. * 25% max. leaching on each edge.
		1 1	ment to be made after keeping at roon	n temp for 24+2	25% max. leaching on each edge.
		hrs.	ment to be made after keeping at room	ii temp. 101 24±2	
12.	Temperature		* Conduct the five cycles according to the temperatures and time.		* No remarkable damage.
	Cycle	Step	Temp. (°C)	Time (min.)	*Cap change: within ±2.5% or ±0.25pF whichever is larger.
	- 1010	1	Min. operating temp. +0/-3	30±3	* Q/D.F., I.R. and dielectric strength: To meet initial requirements.
		2	Room temp.	2~3	, , , , , , , , , , , , , , , , , , ,
		3	Max. operating temp. +3/-0	30±3	
		4	Room temp.	2~3	
		* Measure	ment to be made after keeping at roon	n temp. for 24±2 hrs	

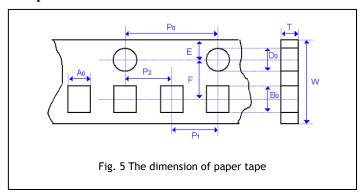


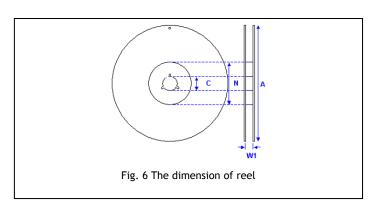
10. RELIABILITY TEST CONDITIONS AND REQUIREMENTS

No.	Item	Test Condition	Requi	rements			
13.	Humidity	* Test temp.: 40±2°C	* No remarkable damage.				
	(Damp Heat)	* Humidity: 90~95% RH	* Cap change: within ±5.0% or ±0.5pF whichever is larger.				
	Steady State	* Test time: 500+24/-0hrs.	* Q/D.F. value: Cap≥30pF, Q≥350;				
		* Measurement to be made after keeping at room temp. for 24±2 hrs.	10pF≤Cap<30pF, Q	≥275+2.5C			
			Cap<10pF; Q≥200+	10C			
14.	Humidity	* Test temp.: 40±2°C	* No remarkable damage.				
	(Damp Heat)	* Humidity: 90~95%RH	* Cap change: within ±7.5% or ±0.75pF whichever is larger.				
	Load	* Test time: 500+24/-0 hrs.	* Q/D.F. value: Cap≥30pF, Q≥200;			* Q/D.F. value: Cap≥30pF, Q≥200;	
		* To apply voltage: rated voltage	Cap<30pF, Q≥100+10/3C				
		* Measurement to be made after keeping at room temp. for 24±2 hrs.	s. * I.R.: ≥500MΩ.				
15.	High	* Test temp.: 125±3°C	* No remarkable damage.				
	Temperature	* To apply voltage: 200% of rated voltage.	* Cap change: within ±3.0% or ±0.3	pF whichever is larger.			
	Load	* Test time: 1000+24/-0 hrs.	* Q/D.F. value: Cap≥30pF, Q≥350				
	(Endurance)	* Measurement to be made after keeping at room temp. for 24±2 hrs.	10pF≤Cap<30pF, Q)≥275+2.5C			
			Cap<10pF, Q≥200+10C				
			* I.R.: ≥1GΩ.				
16.	ESR	The ESR should be measured at room temperature and tested at	0201, 0402	0603			
		frequency 1±0.1 GHz.	$0.5pF \le Cap \le 1pF : < 350m\Omega$	0.3pF≤Cap≤1pF: < 1500mΩ			
			1pF <cap≤5pf: 300mω<="" <="" td=""><td>1pF<cap≤10pf: 250mω<="" <="" td=""></cap≤10pf:></td></cap≤5pf:>	1pF <cap≤10pf: 250mω<="" <="" td=""></cap≤10pf:>			
			5pF <cap≤22pf: 250mω<="" <="" td=""><td>10pF<cap≤47pf: 200mω<="" <="" td=""></cap≤47pf:></td></cap≤22pf:>	10pF <cap≤47pf: 200mω<="" <="" td=""></cap≤47pf:>			

11. APPENDIXES

■ Tape & reel dimensions





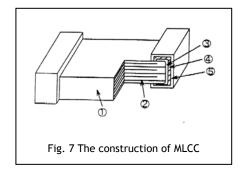
Size	0201	0402	0603	0805
Thickness	L	N	S	Т
A ₀	0.37±0.03	0.62±0.05	1.00 +0.05/-0.1	1.50±0.10
B ₀	0.67±0.03	1.12±0.05	1.80±0.10	2.30±0.10
Т	0.42±0.03	0.60±0.05	0.95±0.05	0.95±0.05
K ₀	-	-	-	-
W	8.00±0.10	8.00±0.10	8.00±0.10	8.00±0.10
P ₀	4.00±0.10	4.00±0.10	4.00±0.10	4.00±0.10
10xP₀	40.0±0.10	40.0±0.10	40.0±0.20	40.0±0.20
P ₁	2.00±0.05	2.00±0.05	4.00±0.10	4.00±0.10
P ₂	2.00±0.05	2.00±0.05	2.00±0.05	2.00±0.05
D_0	1.55±0.05	1.55±0.05	1.55±0.05	1.55±0.05
D ₁	-	-	-	-
E	1.75±0.05	1.75±0.05	1.75±0.05	1.75±0.05
F	3.50±0.05	3.50±0.05	3.50±0.05	3.50±0.05

Size	0201, 0402, 0603, 0805				
Reel size	7"	13"			
C	13.0+0.5/-0.2	13.0+0.5/-0.2			
\mathbf{W}_{1}	8.4+1.5/-0	8.4+1.5/-0			
A	178.0±1.0	330.0±1.0			
N	60.0+1.0/-0	100±1.0			



Constructions

No.	Na	NP0	
1	Ceramic	BaTiO₃ based	
2	Inner el	Cu	
3		Inner layer	Cu
4	Termination	Middle layer	Ni
(5)		Outer layer	Sn (Matt)



■ Storage and handling conditions

- (1) To store products at 5 to 40°C ambient temperature and 20 to 70%. related humidity conditions.
- (2) The product is recommended to be used within one year after shipment. Check solderability in case of shelf life extension is needed. Cautions:
 - a. Don't store products in a corrosive environment such as sulfide, chloride gas, or acid. It may cause oxidization of electrode, which easily be resulted in poor soldering.
 - b. To store products on the shelf and avoid exposure to moisture.
 - c. Don't expose products to excessive shock, vibration, direct sunlight and so on.

■ Recommended soldering conditions

The lead-free termination MLCCs are not only to be used on SMT against lead-free solder paste, but also suitable against lead-containing solder paste. If the optimized solder joint is requested, increasing soldering time, temperature and concentration of N_2 within oven are recommended.

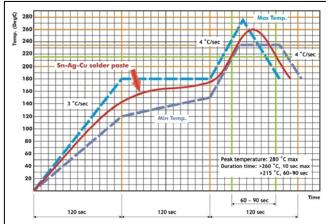


Fig. 8 Recommended IR reflow soldering profile for SMT process with SnAgCu series solder paste.

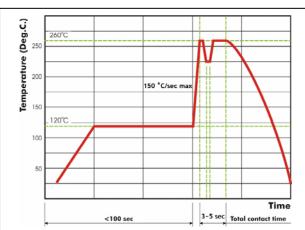


Fig. 9 Recommended wave soldering profile for SMT process with SnAgCu series solder.